8-Bit, High-Speed, Multiplying D/A Converter
(Universal Digital Logic Interface)

**FEATURES**
- Fast Settling Output Current: 85 ns
- Full-Scale Current Prematched to ±1 LSB
- Direct Interface to TTL, CMOS, ECL, HTL, PMOS
- Nonlinearity to 0.1% Maximum over Temperature Range
- High Output Impedance and Compliance: –10 V to +18 V
- Complementary Current Outputs
- Wide Range Multiplying Capability: 1 MHz Bandwidth
- Low FS Current Drift: ±10 ppm/°C
- Wide Power Supply Range: ±4.5 V to ±18 V
- Low Power Consumption: 33 mW @ ±5 V
- Low Cost
- Available in Die Form

**GENERAL DESCRIPTION**
The DAC08 series of 8-bit monolithic digital-to-analog converters provide very high-speed performance coupled with low cost and outstanding applications flexibility.

Advanced circuit design achieves 85 ns settling times with very low “glitch” energy and at low power consumption. Monotonic multiplying performance is attained over a wide 20-to-1 reference current range. Matching to within 1 LSB between reference and full-scale currents eliminates the need for full-scale trimming in most applications. Direct interface to all popular logic families with full noise immunity is provided by the high swing, adjustable threshold logic input.

High voltage compliance complementary current outputs are provided, increasing versatility and enabling differential operation to effectively double the peak-to-peak output swing. In many applications, the outputs can be directly converted to voltage without the need for an external op amp.

All DAC08 series models guarantee full 8-bit monotonicity, and nonlinearities as tight as ±0.1% over the entire operating temperature range are available. Device performance is essentially unchanged over the ±4.5 V to ±18 V power supply range, with 33 mW power consumption attainable at ±5 V supplies.

The compact size and low power consumption make the DAC08 attractive for portable and military/aerospace applications; devices processed to MIL-STD-883, Level B are available.

DAC08 applications include 8-bit, 1 µs A/D converters, servo motor and pen drivers, waveform generators, audio encoders and attenuators, analog meter drivers, programmable power supplies, CRT display drivers, high-speed modems and other applications where low cost, high speed and complete input/output versatility are required.

**FUNCTIONAL BLOCK DIAGRAM**

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**REV. B**

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## DAC08—SPECIFICATIONS

### ELECTRICAL CHARACTERISTICS

*(@ \(V_S = \pm 15 \text{ V}, \ I_{\text{REF}} = 2.0 \text{ mA}, -55^\circ \text{C} \leq T_A \leq +125^\circ \text{C} \) for DAC08A and DAC08B, 0°C \(\leq T_A \leq +70^\circ \text{C} \) for DAC08E and DAC08H, \(-40^\circ \text{C} \) to +85°C for DAC08C, unless otherwise noted. Output characteristics refer to both \(I_{\text{OUT}}\) and \(I_{\text{OUT}}^\circ\).*

<table>
<thead>
<tr>
<th>Parameter</th>
<th>Symbol</th>
<th>Conditions</th>
<th>DAC08A/H</th>
<th>DAC08E</th>
<th>DAC08C</th>
</tr>
</thead>
<tbody>
<tr>
<td>Resolution</td>
<td>(R_{\text{NL}})</td>
<td>8 bits</td>
<td>8 8 8 bits</td>
<td>8 8 8 bits</td>
<td>8 8 Bits</td>
</tr>
<tr>
<td>Monotonicity</td>
<td>(T_i)</td>
<td>T0 (\pm 1/2) LSB, All Bits Switched ON or OFF, (T_A = 25^\circ \text{C})</td>
<td>85 135 ns</td>
<td>85 150 ns</td>
<td>85 150 ns</td>
</tr>
<tr>
<td>Nonlinearity</td>
<td>(T_i)</td>
<td>(\pm 0.1)</td>
<td>85 135 ns</td>
<td>85 150 ns</td>
<td>85 150 ns</td>
</tr>
<tr>
<td>Settling Time</td>
<td>(T_{\text{SETT}})</td>
<td>(\pm 0.19)</td>
<td>85 135 ns</td>
<td>85 150 ns</td>
<td>85 150 ns</td>
</tr>
<tr>
<td>Propagation Delay</td>
<td>(T_{\text{PHL}})</td>
<td>35 60 ns</td>
<td>35 60 ns</td>
<td>35 60 ns</td>
<td>35 60 ns</td>
</tr>
<tr>
<td>Each Bit</td>
<td>(T_{\text{PLH}})</td>
<td>(\pm 0.19)</td>
<td>85 135 ns</td>
<td>85 150 ns</td>
<td>85 150 ns</td>
</tr>
<tr>
<td>All Bits Switched</td>
<td>(T_{\text{TCI}})</td>
<td>(\pm 0.19)</td>
<td>85 135 ns</td>
<td>85 150 ns</td>
<td>85 150 ns</td>
</tr>
<tr>
<td>Full-Scale Tempco</td>
<td>(\Delta V_{\text{FS}}/\Delta T)</td>
<td>(\pm 0.19)</td>
<td>85 135 ns</td>
<td>85 150 ns</td>
<td>85 150 ns</td>
</tr>
<tr>
<td>Output Voltage (True Compliance)</td>
<td>(V_{\text{OC}})</td>
<td>Full-Scale Current</td>
<td>(-10) 18 V</td>
<td>(-10) 18 V</td>
<td>(-10) 18 V</td>
</tr>
<tr>
<td>Full Range Current</td>
<td>(I_{\text{FR}})</td>
<td>(+15.0 \text{ V}, V_{\text{IN}} = \pm 10 \text{ V})</td>
<td>2.1 mA</td>
<td>2.1 mA</td>
<td>2.1 mA</td>
</tr>
<tr>
<td>Full Range Symmetry</td>
<td>(I_{\text{RS}})</td>
<td>(+10.0 \text{ V}, V_{\text{IN}} = \pm 10 \text{ V})</td>
<td>10 18 µA</td>
<td>10 18 µA</td>
<td>10 18 µA</td>
</tr>
<tr>
<td>Zero-Scale Current</td>
<td>(I_{\text{ZS}})</td>
<td>(+10.0 \text{ V}, V_{\text{IN}} = \pm 10 \text{ V})</td>
<td>10 18 µA</td>
<td>10 18 µA</td>
<td>10 18 µA</td>
</tr>
<tr>
<td>Output Current Range</td>
<td>(I_{\text{OR}})</td>
<td>(+15.0 \text{ V}, V_{\text{IN}} = \pm 10 \text{ V})</td>
<td>2.1 mA</td>
<td>2.1 mA</td>
<td>2.1 mA</td>
</tr>
<tr>
<td>Output Current Noise</td>
<td>(I_{\text{REF}})</td>
<td>(+15.0 \text{ V}, V_{\text{IN}} = \pm 10 \text{ V})</td>
<td>2.1 mA</td>
<td>2.1 mA</td>
<td>2.1 mA</td>
</tr>
<tr>
<td>Logic Input Levels</td>
<td>(V_{\text{IL}})</td>
<td>(+15.0 \text{ V}, V_{\text{IN}} = \pm 10 \text{ V})</td>
<td>2 2 2</td>
<td>2 2 2</td>
<td>2 2 2</td>
</tr>
<tr>
<td>Logic Input “1”</td>
<td>(V_{\text{IH}})</td>
<td>(+15.0 \text{ V}, V_{\text{IN}} = \pm 10 \text{ V})</td>
<td>2 2 2</td>
<td>2 2 2</td>
<td>2 2 2</td>
</tr>
<tr>
<td>Logic Input Current Swing</td>
<td>(V_{\text{IS}})</td>
<td>(+15.0 \text{ V}, V_{\text{IN}} = \pm 10 \text{ V})</td>
<td>2 2 2</td>
<td>2 2 2</td>
<td>2 2 2</td>
</tr>
<tr>
<td>Logic Threshold Range</td>
<td>(V_{\text{TH}})</td>
<td>(+15.0 \text{ V}, V_{\text{IN}} = \pm 10 \text{ V})</td>
<td>2 2 2</td>
<td>2 2 2</td>
<td>2 2 2</td>
</tr>
<tr>
<td>Reference Bias Current</td>
<td>(I_{\text{REF}})</td>
<td>(+15.0 \text{ V}, V_{\text{IN}} = \pm 10 \text{ V})</td>
<td>2 2 2</td>
<td>2 2 2</td>
<td>2 2 2</td>
</tr>
<tr>
<td>Reference Input Slew Rate</td>
<td>(dI/dt)</td>
<td>(+15.0 \text{ V}, V_{\text{IN}} = \pm 10 \text{ V})</td>
<td>2 2 2</td>
<td>2 2 2</td>
<td>2 2 2</td>
</tr>
<tr>
<td>Power Supply Sensitivity</td>
<td>(P_{\text{SS}})</td>
<td>(+4.5 \text{ V} \leq V_{\text{IN}} \leq 18 \text{ V})</td>
<td>(+0.0003 \pm 0.01)</td>
<td>(+0.0003 \pm 0.01)</td>
<td>(+0.0003 \pm 0.01)</td>
</tr>
<tr>
<td>Power Supply Current</td>
<td>(I_{\text{P}})</td>
<td>(+5.0 \text{ V}, I_{\text{REF}} = 1.0 \text{ mA})</td>
<td>2.3 3.8 mA</td>
<td>2.3 3.8 mA</td>
<td>2.3 3.8 mA</td>
</tr>
<tr>
<td>Power Dissipation</td>
<td>(P_{\text{D}})</td>
<td>(+5.0 \text{ V}, I_{\text{REF}} = 1.0 \text{ mA})</td>
<td>33 48 mW</td>
<td>33 48 mW</td>
<td>33 48 mW</td>
</tr>
</tbody>
</table>

**NOTES**

1Guaranteed by design.

Specifications subject to change without notice.
The DAC08 contains 84 transistors. Die size 63 mil x 87 mil = 5,481 square mils.

For availability and burn-in information on SO and PLCC packages, contact your local sales office.

NOTES
DAC08GRBC
±
DAC08AQ
±

Model
DAC08AQ
DAC08AQQ/883C
DAC08HP
DAC08HQ
DAC08Q
DAC08Q/Q/883C
DAC08RC/883C
DAC08EP
DAC08EQ
DAC08ES
DAC08ES-REEL
DAC08CP
DAC08CQ
DAC08CS
DAC08CS-REEL
DAC08NBC
DAC08GBC
DAC08GRBC

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7–
7–
7–
7–
7–
7–
7–
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7–
7–
7–
7–
7–
7–

0.39%
0.19%
0.39%
0.19%
0.39%
0.19%
0.39%
0.39%
0.39%
0.39%
0.39%
0.39%
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0.39%

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0.10%
0.10%
0.10%
0.10%
0.10%
0.10%
0.10%
0.10%
0.10%
0.10%
0.10%
0.10%
0.10%
0.10%

Temperature Range
–55°C to +125°C
–55°C to +125°C
0°C to 70°C
0°C to 70°C
–55°C to +125°C
–55°C to +125°C
–55°C to +125°C
0°C to 70°C
0°C to 70°C
0°C to 70°C
0°C to 70°C
–40°C to +85°C
–40°C to +85°C
25°C
25°C
25°C

Package Description
Cerdip-16
Cerdip-16
P-DIP-16
Cerdip-16
Cerdip-16
Cerdip-16
Cerdip-16
Cerdip-16
Cerdip-16
Cerdip-16
Cerdip-16
P-DIP-16
Cerdip-16
DICE
DICE
DICE

Package Option
Q-16
Q-16
N-16
Q-16
Q-16
Q-16
Q-16
Q-16
Q-16
Q-16
Q-16
R-16A (Narrow Body)
R-16A (Narrow Body)

# Parts Per Container
25
25
25
25
25
25
25
25
25
25
25
47
47

ORDERING GUIDE

NOTES
1 Devices processed in total compliance to MIL-STD-883. Consult factory for 883 data sheet.
2 For availability and burn-in information on SO and PLCC packages, contact your local sales office.

The DAC08 contains 84 transistors. Die size 63 mil x 87 mil = 5,481 square mils.

CAUTION
ESD (electrostatic discharge) sensitive device. Electrostatic charges as high as 4000 V readily accumulate on the human body and test equipment and can discharge without detection. Although the DAC08 features proprietary ESD protection circuitry, permanent damage may occur on devices subjected to high-energy electrostatic discharges. Therefore, proper ESD precautions are recommended to avoid performance degradation or loss of functionality.
DAC08

16-Lead Dual-In-Line Package
(Q and P Suffix)

16-Lead SO
(S Suffix)

DAC08RC/883 20-Lead LCC
(RC Suffix)

PIN CONNECTIONS

DICE CHARACTERISTICS
(125°C Tested Dice Available)

1. VLC
2. IOUT
3. V–
4. IOUT
5. BIT 1 (MSB)
6. BIT 2
7. BIT 3
8. BIT 4
9. BIT 5
10. BIT 6
11. BIT 7
12. BIT 8 (LSB)
13. V+
14. VREF (+)
15. VREF (–)
16. COMP

DIE SIZE 0.087 x 0.063 inch, 5,270 sq. mils
(2.209 x 1.60 mm, 3.54 sq. mm)
### DAC08

**WAVER TEST LIMITS**

(@ $V_S = \pm 15$ V, $I_{REF} = 2.0$ mA; $T_A = 25^\circ$C, unless otherwise noted. Output characteristics apply to both I$_{OUT}$ and I$_{OUT}$.)

<table>
<thead>
<tr>
<th>Parameter</th>
<th>Symbol</th>
<th>Conditions</th>
<th>DAC08N Limit</th>
<th>DAC08G Limit</th>
<th>DAC08GR Limit</th>
<th>Unit</th>
</tr>
</thead>
<tbody>
<tr>
<td>Resolution</td>
<td></td>
<td></td>
<td>8</td>
<td>8</td>
<td>8</td>
<td>Bits min</td>
</tr>
<tr>
<td>Monotonicity</td>
<td></td>
<td></td>
<td>8</td>
<td>8</td>
<td>8</td>
<td>Bits min</td>
</tr>
<tr>
<td>Nonlinearity</td>
<td>NL</td>
<td></td>
<td>±0.1</td>
<td>±0.1</td>
<td>±0.39</td>
<td>% FS max</td>
</tr>
<tr>
<td>Output Voltage</td>
<td>V$_{OC}$</td>
<td>Full-Scale Current</td>
<td>+18</td>
<td>+18</td>
<td>+18</td>
<td>V max</td>
</tr>
<tr>
<td>Compliance</td>
<td></td>
<td>Change &lt; 1/2 LSB</td>
<td>−10</td>
<td>−10</td>
<td>−10</td>
<td>V min</td>
</tr>
<tr>
<td>Full-Scale Current</td>
<td>I$_{FS4}$ or</td>
<td>V$_{REF} = 10.000$ V</td>
<td>2.04</td>
<td>2.04</td>
<td>2.04</td>
<td>mA max</td>
</tr>
<tr>
<td></td>
<td>I$_{FS2}$</td>
<td>$R_{14}, R_{15} = 5.000$ k$\Omega$</td>
<td>1.94</td>
<td>1.94</td>
<td>1.94</td>
<td>mA min</td>
</tr>
<tr>
<td>Full-Scale Symmetry</td>
<td>I$_{FSS}$</td>
<td></td>
<td>±8</td>
<td>±8</td>
<td>±16</td>
<td>$\mu$A max</td>
</tr>
<tr>
<td>Zero-Scale Current</td>
<td>I$_{ZS}$</td>
<td></td>
<td>2</td>
<td>4</td>
<td>4</td>
<td>$\mu$A max</td>
</tr>
<tr>
<td>Output Current Range</td>
<td>I$_{FS1}$ or</td>
<td>V$<em>{-} = −10$ V, $V</em>{REF} = +15$ V, $V_{-} = −12$ V, $V_{REF} = +25$ V, $R_{14}, R_{15} = 5.000$ k$\Omega$</td>
<td>2.1</td>
<td>2.1</td>
<td>2.1</td>
<td>mA min</td>
</tr>
<tr>
<td>Logic Input “0”</td>
<td>V$_{IL}$</td>
<td></td>
<td>0.8</td>
<td>0.8</td>
<td>0.8</td>
<td>V max</td>
</tr>
<tr>
<td>Logic Input “1”</td>
<td>V$_{IH}$</td>
<td></td>
<td>2</td>
<td>2</td>
<td>2</td>
<td>V min</td>
</tr>
<tr>
<td>Logic Input Current</td>
<td></td>
<td>$V_{LC} = 0$ V</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Logic “0”</td>
<td>I$_{IL}$</td>
<td>$V_{IN} = −10$ V to +0.8 V</td>
<td>±10</td>
<td>±10</td>
<td>±10</td>
<td>$\mu$A max</td>
</tr>
<tr>
<td>Logic “1”</td>
<td>I$_{IH}$</td>
<td>$V_{IN} = +2.0$ V to +18 V</td>
<td>±10</td>
<td>±10</td>
<td>±10</td>
<td>$\mu$A max</td>
</tr>
<tr>
<td>Logic Input Swing</td>
<td>V$_{IS}$</td>
<td>$V_{-} = −15$ V</td>
<td>+18</td>
<td>+18</td>
<td>+18</td>
<td>V max</td>
</tr>
<tr>
<td></td>
<td></td>
<td>$−10$</td>
<td>−10</td>
<td>−10</td>
<td>−10</td>
<td>V min</td>
</tr>
<tr>
<td>Reference Bias Current</td>
<td>I$_{15}$</td>
<td></td>
<td>−3</td>
<td>−3</td>
<td>−3</td>
<td>$\mu$A max</td>
</tr>
<tr>
<td>Power Supply</td>
<td>P$SS_{IPS+}$</td>
<td>$V_{+} = +4.5$ V to +18 V</td>
<td>0.01</td>
<td>0.01</td>
<td>0.01</td>
<td>% FS/% V max</td>
</tr>
<tr>
<td>Sensitivity</td>
<td>P$SS_{IPS-}$</td>
<td>$V_{-} = −4.5$ V to −18 V</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>$I_{REF} = 1.0$ mA</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Power Supply Current</td>
<td>I$+$</td>
<td>$V_{S} = ±15$ V</td>
<td>3.8</td>
<td>3.8</td>
<td>3.8</td>
<td>mA max</td>
</tr>
<tr>
<td></td>
<td></td>
<td>$I_{REF} \leq 2.0$ mA</td>
<td>−7.8</td>
<td>−7.8</td>
<td>−7.8</td>
<td>$\mu$A max</td>
</tr>
<tr>
<td>Power Dissipation</td>
<td>P$D$</td>
<td>$V_{S} = ±15$ V</td>
<td>174</td>
<td>174</td>
<td>174</td>
<td>mW max</td>
</tr>
<tr>
<td></td>
<td></td>
<td>$I_{REF} \leq 2.0$ mA</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
</tbody>
</table>

**NOTE**

Electrical tests are performed at wafer probe to the limits shown. Due to variations in assembly methods and normal yield loss, yield after packaging is not guaranteed for standard product dice. Consult factory to negotiate specifications based on dice lot qualification through sample lot assembly and testing.
**DAC08**

**Figure 1. Pulsed Reference Operation**

**Figure 2. Burn-in Circuit**

**Figure 3. Fast Pulsed Reference Operation**

**Figure 4. True and Complementary Output Operation**

**Figure 5. LSB Switching**

**Figure 6. Full-Scale Settling Time**
Typical Performance Characteristics—DAC08

TPC 1. Full-Scale Current vs. Reference Current

TPC 2. LSB Propagation Delay vs. $I_{FS}$

TPC 3. Reference Input Frequency Response

TPC 4. Reference Amp Common-Mode Range

TPC 5. Logic Input Current vs. Input Voltage

TPC 6. $V_{TH} - V_{LC}$ vs. Temperature

TPC 7. Output Current vs. Output Voltage (Output Voltage Compliance)

TPC 8. Output Voltage Compliance vs. Temperature

TPC 9. Bit Transfer Characteristics

NOTE: B1 THROUGH B8 HAVE IDENTICAL TRANSFER CHARACTERISTICS. BITS ARE FULLY SWITCHED WITH LESS THAN 1/2 LSB ERROR AT LESS THAN $0.1$ V OFF THRESHOLD. THESE SWITCHING POINTS ARE GUARANTEED TO LIE BETWEEN $0.8$ V AND $2.0$ V OVER THE OPERATING TEMPERATURE RANGE ($V_{LC} = 0.2$ V).
DAC08

TPC 10. Power Supply Current vs. V+

TPC 11. Power Supply Current vs. V–

TPC 12. Power Supply Current vs. Temperature

BASIC CONNECTIONS

Figure 7. Accommodating Bipolar References

Figure 8. Basic Positive Reference Operation

Figure 9. Basic Unipolar Negative Operation
Figure 11. Recommended Full-Scale Adjustment Circuit

Figure 12. Basic Negative Reference Operation

Figure 13. Offset Binary Operation

Figure 14. Positive Low Impedance Output Operation

Figure 15. Negative Low Impedance Output Operation

Figure 16. Interfacing with Various Logic Families
DAC08

APPLICATION INFORMATION

REFERENCE AMPLIFIER SETUP

The DAC08 is a multiplying D/A converter in which the output current is the product of a digital number and the input reference current. The reference current may be fixed or may vary from nearly zero to 4.0 mA. The full-scale output current is a linear function of the reference current and is given by:

\[ I_{FR} = \frac{255}{256} \times I_{REF} \]

where \( I_{REF} = I_{I4} \)

In positive reference applications, an external positive reference voltage forces current through R14 into the \( V_{REF(+)\text{ }} \) terminal (Pin 14) of the reference amplifier. Alternatively, a negative reference may be applied to \( V_{REF(-)} \) at Pin 15; reference current flows from ground through R14 into \( V_{REF(-)} \) as in the positive reference case. This negative reference connection has the advantage of a very high impedance presented at Pin 15. The voltage at Pin 14 is equal to and tracks the voltage at Pin 15 due to the high gain of the internal reference amplifier. R15 (nominally equal to R14) is used to cancel bias current errors; R15 may be eliminated with only a minor increase in error.

Bipolar references may be accommodated by offsetting \( V_{REF} \) or \( V_{Pin} \). The negative common-mode range of the reference amplifier is given by: \( V_{CM(-)} = V– \) plus \( (I_{REF} \times 1 \, kΩ) \) plus 2.5 V. The positive common-mode range is \( V+ \) less 1.5 V.

When a dc reference is used, a reference bypass capacitor is recommended. A 5.0 V TTL logic supply is not recommended as a reference. If a regulated power supply is used as a reference, R14 should be split into two resistors with the junction bypassed to ground with a 0.1 \( \mu F \) capacitor.

For most applications the tight relationship between \( I_{REF} \) and \( I_{FS} \) will eliminate the need for trimming \( I_{REF} \). If required, full-scale trimming may be accomplished by adjusting the value of R14, or by using a potentiometer for R14. An improved method of full-scale trimming which eliminates potentiometer T.C. effects is shown in the recommended full-scale adjustment circuit.

Using lower values of reference current reduces negative power supply current and increases reference amplifier negative common-mode range. The recommended range for operation with a dc reference current is 0.2 mA to 4.0 mA.

REFERENCE AMPLIFIER COMPENSATION FOR MULTIPLYING APPLICATIONS

AC reference applications will require the reference amplifier to be compensated using a capacitor from Pin 16 to V–. The value of this capacitor depends on the impedance presented to Pin 14: for R14 values of 1.0, 2.5 and 5.0 kΩ, minimum values of \( C_C \) are 15, 75 and 75 pF. Larger values of R14 require proportionately increased values of \( C_C \) for proper phase margin, so the ratio of \( C_C \) (pF) to R14 (kΩ) = 15.

For fastest response to a pulse, low values of R14 enabling small \( C_C \) values should be used. If Pin 14 is driven by a high impedance such as a transistor current source, none of the above values will suffice and the amplifier must be heavily compensated which will decrease overall bandwidth and slew rate. For R14 = 1 kΩ and \( C_C = 15 \, pF \), the reference amplifier slew at 4 mA/μs enabling a transition from \( I_{REF} = 0 \) to \( I_{REF} = 2 \, mA \) in 500 ns.

Operation with pulse inputs to the reference amplifier may be accommodated by an alternate compensation scheme. This technique provides lowest full-scale transition times. An internal clamp allows quick recovery of the reference amplifier from a cutoff (\( I_{REF} = 0 \)) condition. Full-scale transition (0 mA to 2 mA) occurs in 120 ns when the equivalent impedance at Pin 14 is 200 Ω and \( C_C = 0 \). This yields a reference slew rate of 16 mA/μs, which is relatively independent of \( R_{IN} \) and \( V_{IN} \) values.

LOGIC INPUTS

The DAC08 design incorporates a unique logic input circuit that enables direct interface to all popular logic families and provides maximum noise immunity. This feature is made possible by the large input swing capability, 2 \( \mu A \) logic input current and completely adjustable logic threshold voltage. For \( V– = −15 \, V \), the logic inputs may swing between −10 V and +18 V. This enables direct interface with 15 V CMOS logic, even when the DAC08 is powered from a 5 V supply. Minimum input logic swing and minimum logic threshold voltage are given by: \( V– \) plus \( (I_{REF} \times 1 \, kΩ) \) plus 2.5 V. The logic threshold may be adjusted over a wide range by placing an appropriate voltage at the logic threshold control pin (Pin 1, \( V_{L(C)} \)). The appropriate graph shows the relationship between \( V_{L(C)} \) and \( V_{TH} \) over the temperature range, with \( V_{TH} \) nominally 1.4 above \( V_{L(C)} \). For TTL and DTL interface, simply ground pin 1. When interfacing ECL, \( I_{REF} = 1 \, mA \) is recommended. For interfacing other logic families, see preceding page. For general set-up of the logic control circuit, it should be noted that Pin 1 will source 100 \( \mu \)A typical; external circuitry should be designed to accommodate this current.

Fastest settling times are obtained when Pin 1 sees a low impedance. If Pin 1 is connected to a 1 kΩ divider, for example, it should be bypassed to ground by a 0.01 \( \mu F \) capacitor.

ANALOG OUTPUT CURRENTS

Both true and complemented output sink currents are provided where \( I_0 \) = \( I_0 \) = \( I_{FS} \). Current appears at the “true” (\( I_0 \)) output when a “1” (logic high) is applied to each logic input. As the binary count increases, the sink current at pin 4 increases proportionally, in the fashion of a “positive logic” D/A converter. When a “0” is applied to any input bit, that current is turned off at Pin 4 and turned on at Pin 2. A decreasing logic count increases \( I_0 \) as in a negative or inverted logic D/A converter. Both outputs may be used simultaneously. If one of the outputs is not required, it must be connected to ground or to a point capable of sourcing \( I_{FS} \) do not leave an unused output pin open.

Both outputs have an extremely wide voltage compliance enabling fast direct current-to-voltage conversion through a resistor tied to ground or other voltage source. Positive compliance is 36 V above V– and is independent of the positive supply. Negative compliance is given by \( V– \) plus \( (I_{REF} \times 1 \, kΩ) \) plus 2.5 V.

The dual outputs enable double the usual peak-to-peak load swing when driving loads in quasi-differential fashion. This feature is especially useful in cable driving, CRT deflection and in other balanced applications such as driving center-tapped coils and transformers.

POWER SUPPLIES

The DAC08 operates over a wide range of power supply voltages from a total supply of 9 V to 36 V. When operating at supplies of \( \pm 5 \, V \) or less, \( I_{REF} \leq 1 \, mA \) is recommended. Low reference current operation decreases power consumption and increases negative compliance, reference amplifier negative common-mode
The DAC08 provides excellent multiplying performance with an extremely linear relationship between $I_{LS}$ and $I_{REF}$ over a range of 4 µA to 4 mA. Monotonic operation is maintained over a typical range of $I_{REF}$ from 100 µA to 4.0 mA. SETTLING TIME

The DAC08 is capable of extremely fast settling times, typically 85 ns at $I_{REF} = 2.0$ mA. Judicious circuit design and careful board layout must be employed to obtain full performance potential during testing and application. The logic switch design enables propagation delays of only 35 ns for each of the 8 bits. Settling time to within 1/2 LSB of the LSB is therefore 35 ns, with each progressively larger bit taking successively longer. The MSB settles in 85 ns, thus determining the overall settling time of 85 ns. Settling to 6-bit accuracy requires about 65 ns to 70 ns. The output capacitance of the DAC08 including the package is approximately 15 pF, therefore the output RC time constant dominates settling time if $R_c > 500$ Ω.

Settling time and propagation delay are relatively insensitive to logic input amplitude and rise and fall times, due to the high gain of the logic switches. Settling time also remains essentially constant for $I_{REF}$ values. The principal advantage of higher $I_{REF}$ values lies in the ability to attain a given output level with lower load resistors, thus reducing the output RC time constant.

Measurement of settling time requires the ability to accurately resolve ±4 µA, therefore a 1 kΩ load is needed to provide adequate drive for most oscilloscopes. The settling time fixture shown in schematic labelled “Settling Time Measurement” uses a cascade design to permit driving a 1 kΩ load with less than 5 pF of parasitic capacitance at the measurement node. At $I_{REF}$ values of less than 1.0 mA, excessive RC damping of the output is difficult to prevent while maintaining adequate sensitivity. However, the major carry from 01111111 to 10000000 provides an accurate indicator of settling time. This code change does not require the normal 6.2 time constants to settle to within ±0.2% of the final value, and thus settling times may be observed at lower values of $I_{REF}$.

DAC08 switching transients or “glitches” are very low and may be further reduced by small capacitive loads at the output at a minor sacrifice in settling time. Fastest operation can be obtained by using short leads, minimizing output capacitance and load resistor values, and by adequate bypassing at the supply, reference, and $V_{LC}$ terminals. Supplies do not require large electrolytic bypass capacitors as the supply current drain is independent of input logic states; 0.1 µF capacitors at the supply pins provide full transient protection.

![Figure 17. Settling Time Measurement](image-url)
OUTLINE DIMENSIONS
Dimensions shown in inches and (mm).

16-Lead Plastic DIP (N-16)

16-Lead Cerdip (Q-16)

16-Lead SO (R-16A)

20-Terminal Leadless Chip Carrier (E-20)

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